Notice of References Cited Application/Control No. 10/509,969 Applicant(s)/Patent Under Reexamination HAUKE ET AL. Examiner BRIAN P. YENKE 2622 Applicant(s)/Patent Under Reexamination HAUKE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0031060	02-2004	Kondo, Tetsujiro	725/131
	В	US-			
	O	US-			
	О	US-			
	Е	US-			
	F	US-			
	O	US-			
	Ι	US-		1	
	_	US-			
	7	US-			
	K	US-			
	Ш	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
-	Ø					
4	R					
	S					
	1				1 C.	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.